

Notic of Referenc s Cited	Application/Control No. 09/785,424	Applicant(s)/Patent Under Reexamination PARK ET AL.	
	Examiner David Y. Chung	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,691,791	11-1997	Nakamura et al.	349/113
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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